



Testing Laboratory

3024

Test Report No:  
2490281R-RFNAV02S-B

## RF EXPOSURE EVALUATION DECLARATION

Product Name	goRAN LTE Base Station
Brand Name	
Model No.	BS1AL-D54US
FCC ID	2AXTDBS1ALD54US
Applicant's Name / Address	Ubiik Inc. 19F., No. 17, Sec. 1, Chengde Rd., Datong Dist., Taipei City 103, Taiwan (R.O.C.)
Manufacturer's Name / Address	Ubiik Inc. 19F., No. 17, Sec. 1, Chengde Rd., Datong Dist., Taipei City 103, Taiwan (R.O.C.)
Test Method Requested, Standard	FCC CFR Title 47 Part 2.1091 Radiofrequency radiation exposure evaluation: mobile devices.
Verdict Summary	IN COMPLIANCE
Documented By	Vera Hsu Vera Hsu
Approved By	 Allen Lin
Date of Receipt	Sep. 09, 2024
Date of Issue	Oct. 21, 2024
Report Version	V1.0

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## Competences and Guarantees

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DEKRA is a testing laboratory competent to carry out the tests described in this report.

In order to assure the traceability to other national and international laboratories, DEKRA has a calibration and maintenance program for its measurement equipment.

DEKRA guarantees the reliability of the data presented in this report, which is the result of the measurements and the tests performed to the item under test on the date and under the conditions stated in the report and it is based on the knowledge and technical facilities available at DEKRA at the time of performance of the test.

DEKRA is liable to the client for the maintenance of the confidentiality of all information related to the item under test and the results of the test.

The results presented in this Test Report apply only to the particular item under test established in this document.

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## General Conditions

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1. The test results relate only to the samples tested.
2. The test results shown in the test report are traceable to the national/international standard through the calibration report of the equipment and evaluated measurement uncertainty herein.
3. This report must not be used to claim product endorsement by TAF or any agency of the government.
4. The test report shall not be reproduced without the written approval of DEKRA Testing and Certification Co., Ltd.
5. Measurement uncertainties evaluated for each testing system and associated connections are given here to provide the system information for reference. Compliance determinations do not take into account measurement uncertainties for each testing system, but are based on the results of the compliance measurement.

## Revision History

Version	Description	Issued Date
V1.0	Initial issue of report	Oct. 21, 2024

## Permissive Change

Report No.	Version	Description	Issued Date
2410704R-RFUSV17S-A	V1.0	Original application.	Apr. 15, 2024
2450097R-RFNAV02S-A	V1.0	<u>Class II Permissive Change (C2PC)</u> Add a new WWAN antenna (Model: 750 10074) of the same type as the original application with higher gain.	Jun. 24, 2024
2490281R-RFNAV02S-B	V1.0	<u>Class II Permissive Change (C2PC)</u> 1. Change Control Board RX as below description. a. Change HPL6 to 0402 100pF from 0402 0Ω. b. Change C675 to 0402 100pF from 0402 33pF. c. Remove CON102 MCX connector. d. Change CON102 to R49.9Ω to ground. e. Solder a 50 ohm copper pipe to FLM7 and connect it to ground. 2. Change PA Board as below description. Add 4pcs RC1206 510 Ω resistors above PC15, PC17, PC18, PC16 capacitors. After evaluating, the worst result of original report is selected to verify radiated emission and record in the report.	Oct. 21, 2024

## 1. General Information

### 1.1. EUT Description

RF General Information			
Evaluation Mode	Band	Operating Frequency Range (MHz)	Modulation Type
LTE-M	Band 54	Uplink: 1670 ~ 1675 Downlink: 1670 ~ 1675	QPSK / 16QAM

The EUT supports two radio functions, a chip on board and the other is a certified WWAN module, and the WWAN module detail as below.

Brand Name	Model No.	FCC ID	Band	Operating Frequency Range (MHz)	Modulation Type
UBIIK	RC7611-1	2AXTDRC76B	LTE Band 2	Uplink: 1850 ~ 1910 Downlink: 1930 ~ 1990	QPSK / 16QAM
			LTE Band 5	Uplink: 824 ~ 849 Downlink: 869 ~ 894	
			LTE Band 12	Uplink: 699 ~ 716 Downlink: 729 ~ 746	
			LTE Band 13	Uplink: 777 ~ 787 Downlink: 746 ~ 756	
			LTE Band 14	Uplink: 788 ~ 798 Downlink: 758 ~ 768	
			LTE Band 25	Uplink: 1850 ~ 1915 Downlink: 1930 ~ 1995	
			LTE Band 26	Uplink: 814 ~ 849 Downlink: 859 ~ 894	
			LTE Band 71	Uplink: 663 ~ 698 Downlink: 617 ~ 652	

Note: The above EUT information is declared by the manufacturer.

## 1.2. Testing Location Information

Testing Location Information		
Test Laboratory : DEKRA Testing and Certification Co., Ltd.		
1 (TAF: 3024)	ADD: No.372-2, Sec. 4, Zhongxing Rd., Zhudong Township, Hsinchu County 31061, Taiwan, R.O.C. TEL: +886-3-582-8001 FAX: +886-3-582-8958 Test site Designation No. TW3024 with FCC. Conformity Assessment Body Identifier (CABID) TW3024 with ISED.	
2 (TAF: 3024)	ADD: No.372, Sec. 4, Zhongxing Rd., Zhudong Township, Hsinchu County 31061, Taiwan, R.O.C. TEL: +886-3-582-8001 FAX: +886-3-582-8958 Test site Designation No. TW3024 with FCC. Conformity Assessment Body Identifier (CABID) TW3024 with ISED.	
Test site number for address 1 includes HC-SR02. Test site number for address 2 includes HC-CB02, HC-CB03, HC-CB04, HC-SR10 and HC-SR12.		

## 2. RF Exposure Evaluation

### 2.1. Test Limit

(A) Test Limit for Occupational / Controlled Exposure

Frequency Range (MHz)	Electric Field Strength (E) (V/m)	Magnetic Field Strength (H) (A/m)	Power Density (S) (mW/ cm <sup>2</sup> )	Averaging Time  E  <sup>2</sup> , H  <sup>2</sup> or S (minutes)
0.3-3.0	614	1.63	*(100)	<6
3.0-30	1842/f	4.89/f	*(900/f <sup>2</sup> )	<6
30-300	61.4	0.163	1.0	<6
300-1500	-	-	f/300	<6
1500-100,000	-	-	5	<6

(B) Test Limit for General Population / Uncontrolled Exposure

Frequency Range (MHz)	Electric Field Strength (E) (V/m)	Magnetic Field Strength (H) (A/m)	Power Density (S) (mW/ cm <sup>2</sup> )	Averaging Time  E  <sup>2</sup> , H  <sup>2</sup> or S (minutes)
0.3-1.34	614	1.63	*(100)	<30
1.34-30	824/f	2.19/f	*(180/f <sup>2</sup> )	<30
30-300	27.5	0.073	0.2	<30
300-1500	-	-	f/1500	<30
1500-100,000	-	-	1.0	<30

Note: f = frequency in MHz; \*Plane-wave equivalent power density

Power Density (S) is calculated by the following formula:

$$S = (P \cdot G) / 4\pi R^2$$

where:

S = power density (in appropriate units, e.g. mW/ cm<sup>2</sup>)

P = power input to the antenna (in appropriate units, e.g., mW)

G = power gain of the antenna in the direction of interest relative to an isotropic radiator

$\pi$  = 3.1416

R = distance to the center of radiation of the antenna (appropriate units, e.g., cm)

## 2.2. Test Result of RF Exposure Evaluation

### Exposure Environment: General Population / Uncontrolled Exposure

#### WWAN LTE of EUT

Evaluation Mode	Maximum Conducted Output Power (dBm)	Actual Antenna Gain (dBi)	E.I.R.P (dBm)	E.I.R.P (mW)	Power Density (mW/cm <sup>2</sup> )	Limit (mW/cm <sup>2</sup> )	Test Result (PASS/FAIL)
LTE Band 54	27.00	8.00	35.000	3162.278	0.280	1.000	PASS

Evaluation Mode	Maximum Conducted Output Power (dBm)	Max Antenna Gain to Meet Limit (dBi)	E.I.R.P (dBm)	E.I.R.P (mW)	Power Density (mW/cm <sup>2</sup> )	Limit (mW/cm <sup>2</sup> )	Test Result (PASS/FAIL)
LTE Band 54	27.00	13.00	40.000	10000.000	0.884	1.000	PASS

#### WWAN LTE of WWAN module

Evaluation Mode	Maximum Conducted Output Power (dBm)	Antenna Gain (dBi)	E.I.R.P (dBm)	E.I.R.P (mW)	Power Density (mW/cm <sup>2</sup> )	Limit (mW/cm <sup>2</sup> )	Test Result (PASS/FAIL)
LTE Band 2	24.00	1.80	25.800	380.189	0.034	1.000	PASS
LTE Band 5	24.00	0.00	24.000	251.189	0.022	0.549	PASS
LTE Band 12	24.00	-0.80	23.200	208.930	0.018	0.466	PASS
LTE Band 13	24.00	1.40	25.400	346.737	0.031	0.518	PASS
LTE Band 14	24.00	1.40	25.400	346.737	0.031	0.525	PASS
LTE Band 25	24.00	1.80	25.800	380.189	0.034	1.000	PASS
LTE Band 26	24.00	-0.50	23.500	223.872	0.020	0.543	PASS
LTE Band 71	24.00	-1.50	22.500	177.828	0.016	0.442	PASS

#### Co-location

##### Conclusion:

The formula of calculated the MPE is:

**CPD1 / LPD1 + CPD2 / LPD2 + .....etc. < 1**

**CPD = Calculation power density**

**LPD = Limit of power density**

WWAN LTE of EUT + WWAN LTE of WWAN module = 0.884 + 0.059 = 0.943, therefore the maximum calculations of above situations are less than the "1" limit.

Note:

1. Distance (cm): 30 for Maximum Permissible Exposure.
2. The above EUT information is declared by the manufacturer.
3. The results are based on the maximum power.